

# April 2008

# FDMA530PZ Single P-Channel PowerTrench<sup>®</sup> MOSFET -30V, -6.8A, $35m\Omega$

# Features

**FAIRCHILD** 

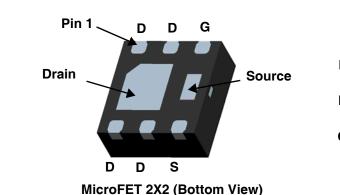
- Max  $r_{DS(on)} = 35m\Omega$  at  $V_{GS} = -10V$ ,  $I_D = -6.8A$
- Max  $r_{DS(on)} = 65m\Omega$  at  $V_{GS} = -4.5V$ ,  $I_D = -5.0A$
- Low profile 0.8mm maximum in the new package MicroFET 2X2 mm
- HBM ESD protection level > 3kV typical (Note 3)
- RoHS Compliant

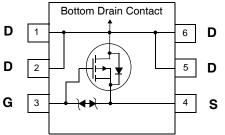


# **General Description**

This device is designed specifically for battery charge or load switching in cellular handset and other ultraportable applications. It features a MOSFET with low on-state resistance.

The MicroFET 2X2 package offers exceptional thermal performance for its physical size and is well suited to linear mode applications.





## MOSFET Maximum Ratings T<sub>A</sub> = 25°C unless otherwise noted

Symbol	Parameter	Ratings	Units		
V <sub>DS</sub>	Drain to Source Voltage		-30	V	
V <sub>GS</sub>	Gate to Source Voltage		±25	V	
I <sub>D</sub>	Drain Current -Continuous	(Note 1a)	-6.8	— A	
	-Pulsed		-24		
D	Power Dissipation	(Note 1a)	2.4	14/	
P <sub>D</sub>	Power Dissipation	(Note 1b)	0.9	W	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range		-55 to +150	°C	

### **Thermal Characteristics**

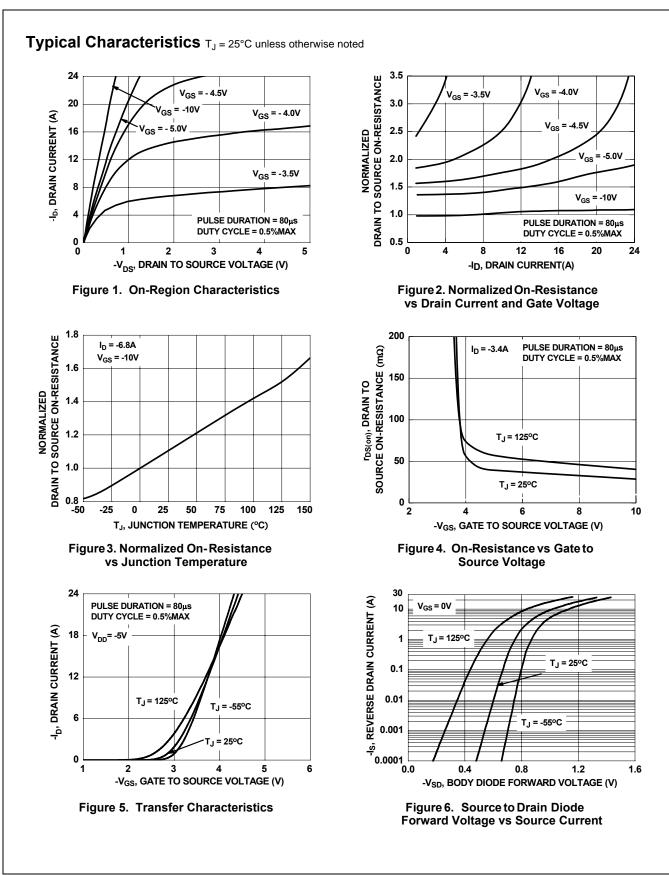
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	52	°C/W
$R_{ ext{ heta}JA}$	Thermal Resistance, Junction to Ambient	(Note 1b)	145	C/VV

## Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
530	FDMA530PZ	MicroFET 2X2	7"	8mm	3000 units

Cteristics Drain to Source Breakdown Voltage Breakdown Voltage Temperature Coefficient				Max	Units
Breakdown Voltage Temperature					
Breakdown Voltage Temperature	I <sub>D</sub> = -250μA, V <sub>GS</sub> = 0V	-30			V
Coemcient	$I_D = -250\mu$ A, referenced to 25°C		-23		mV/°C
Zero Gate Voltage Drain Current	$V_{DS} = -24V, V_{GS} = 0V$			-1	μA
Gate to Source Leakage Current	$V_{GS} = \pm 25V, V_{DS} = 0V$			±10	μA
cteristics					-j
	$V_{00} = V_{00}$ $I_0 = -250 \mu A$	_1	-21	_3	V
		•		5	
Temperature Coefficient	5		5.4		mV/°C
			30	35	-
Static Drain to Source On Resistance			-		mΩ
			-	63	0
Forward Transconductance	$v_{\rm DS} = -10v, \ I_{\rm D} = -6.8A$		17		S
Characteristics					
Input Capacitance	$\gamma = 15\gamma \gamma = -0\gamma$		805	1070	pF
Output Capacitance			155	210	pF
Reverse Transfer Capacitance			130	195	pF
Characteristics					
			6	12	ns
Turn-On Delay Time Rise Time	$V_{DD} = -15V, I_D = -6.8A$		6 21	12 34	ns ns
Turn-On Delay Time	$^{}$ V <sub>DD</sub> = -15V, I <sub>D</sub> = -6.8A 				
Turn-On Delay Time Rise Time			21	34	ns
Turn-On Delay Time Rise Time Turn-Off Delay Time	$V_{GS} = -10V, R_{GEN} = 6\Omega$		21 43	34 69	ns ns
Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time	$V_{GS} = -10V, R_{GEN} = 6\Omega$		21 43 31	34 69 50	ns ns ns
Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge	$V_{GS} = -10V, R_{GEN} = 6\Omega$ $V_{GS} = -10V$		21 43 31 16	34 69 50 24	ns ns ns nC
Turn-On Delay TimeRise TimeTurn-Off Delay TimeFall TimeTotal Gate ChargeTotal Gate Charge	$V_{GS} = -10V, R_{GEN} = 6\Omega$		21 43 31 16 9	34 69 50 24	ns ns nS nC nC
Turn-On Delay TimeRise TimeTurn-Off Delay TimeFall TimeTotal Gate ChargeTotal Gate ChargeGate to Source Gate Charge	$V_{GS} = -10V, R_{GEN} = 6\Omega$		21 43 31 16 9 3.1	34 69 50 24	ns ns nC nC nC
Turn-On Delay TimeRise TimeTurn-Off Delay TimeFall TimeTotal Gate ChargeTotal Gate ChargeGate to Source Gate ChargeGate to Drain "Miller" Charge	$V_{GS} = -10V, R_{GEN} = 6\Omega$ $V_{GS} = -10V$ $V_{DD} = -15V$ $I_{D} = -6.8A$		21 43 31 16 9 3.1	34 69 50 24	ns ns nC nC nC
Turn-On Delay Time         Rise Time         Turn-Off Delay Time         Fall Time         Total Gate Charge         Total Gate Charge         Gate to Source Gate Charge         Gate to Drain "Miller" Charge	$V_{GS} = -10V, R_{GEN} = 6\Omega$ $V_{GS} = -10V$ $V_{DD} = -15V$ $I_{D} = -6.8A$		21 43 31 16 9 3.1	34 69 50 24 11	ns ns nC nC nC nC
Turn-On Delay Time         Rise Time         Turn-Off Delay Time         Fall Time         Total Gate Charge         Total Gate Charge         Gate to Source Gate Charge         Gate to Drain "Miller" Charge         Irce Diode Characteristics         Maximum Continuous Drain-Source Diode	$V_{GS} = -10V, R_{GEN} = 6\Omega$ $V_{GS} = -10V$ $V_{DD} = -15V$ $V_{DD} = -6.8A$ He Forward Current		21 43 31 16 9 3.1 4.5	34 69 50 24 11	ns ns nC nC nC nC
	Gate to Source Threshold Voltage         Gate to Source Threshold Voltage         Temperature Coefficient         Static Drain to Source On Resistance         Forward Transconductance         Characteristics         Input Capacitance         Output Capacitance         Reverse Transfer Capacitance	Gate to Source Threshold Voltage $V_{GS} = V_{DS}$ , $I_D = -250\mu A$ Gate to Source Threshold Voltage Temperature Coefficient $I_D = -250\mu A$ , referenced to 25°CStatic Drain to Source On Resistance $V_{GS} = -10V$ , $I_D = -6.8A$ Static Drain to Source On Resistance $V_{GS} = -10V$ , $I_D = -6.8A$ , $T_J = 125°C$ Forward Transconductance $V_{DS} = -10V$ , $I_D = -6.8A$ CharacteristicsInput Capacitance $V_{DS} = -15V$ , $V_{GS} = 0V$ , $f = 1MHz$	Gate to Source Threshold Voltage $V_{GS} = V_{DS}$ , $I_D = -250\mu$ A       -1         Gate to Source Threshold Voltage $I_D = -250\mu$ A, referenced to 25°C       I         Temperature Coefficient $V_{GS} = -10V$ , $I_D = -6.8A$ V         Static Drain to Source On Resistance $V_{GS} = -10V$ , $I_D = -6.8A$ V         Forward Transconductance $V_{DS} = -10V$ , $I_D = -6.8A$ , $T_J = 125°C$ V         Forward Transconductance $V_{DS} = -10V$ , $I_D = -6.8A$ Operation         Characteristics       Input Capacitance $V_{DS} = -15V$ , $V_{GS} = 0V$ , $f = 1MHz$	Gate to Source Threshold Voltage $V_{GS} = V_{DS}$ , $I_D = -250\mu A$ $-1$ $-2.1$ Gate to Source Threshold Voltage Temperature Coefficient $I_D = -250\mu A$ , referenced to $25^{\circ}C$ $5.4$ Static Drain to Source On Resistance $V_{GS} = -10V$ , $I_D = -6.8A$ $30$ VGS = -10V, $I_D = -6.8A$ $30$ VGS = -10V, $I_D = -6.8A$ $52$ VGS = -10V, $I_D = -6.8A$ , $T_J = 125^{\circ}C$ $43$ Forward Transconductance $V_{DS} = -10V$ , $I_D = -6.8A$ $17$ CharacteristicsInput Capacitance $V_{DS} = -15V$ , $V_{GS} = 0V$ , $f = 1MHz$ $805$	Gate to Source Threshold Voltage $V_{GS} = V_{DS}$ , $I_D = -250\mu A$ $-1$ $-2.1$ $-3$ Gate to Source Threshold Voltage Temperature Coefficient $I_D = -250\mu A$ , referenced to $25^{\circ}C$ $5.4$ Static Drain to Source On Resistance $V_{GS} = -10V$ , $I_D = -6.8A$ $30$ $35$ V_{GS} = -4.5V, $I_D = -5.0A$ $52$ $65$ $V_{GS} = -10V$ , $I_D = -6.8A$ , $T_J = 125^{\circ}C$ $43$ $63$ Forward Transconductance $V_{DS} = -10V$ , $I_D = -6.8A$ $17$ CharacteristicsInput Capacitance $V_{DS} = -15V$ , $V_{GS} = 0V$ , $f = 1MHz$ $805$ $1070$

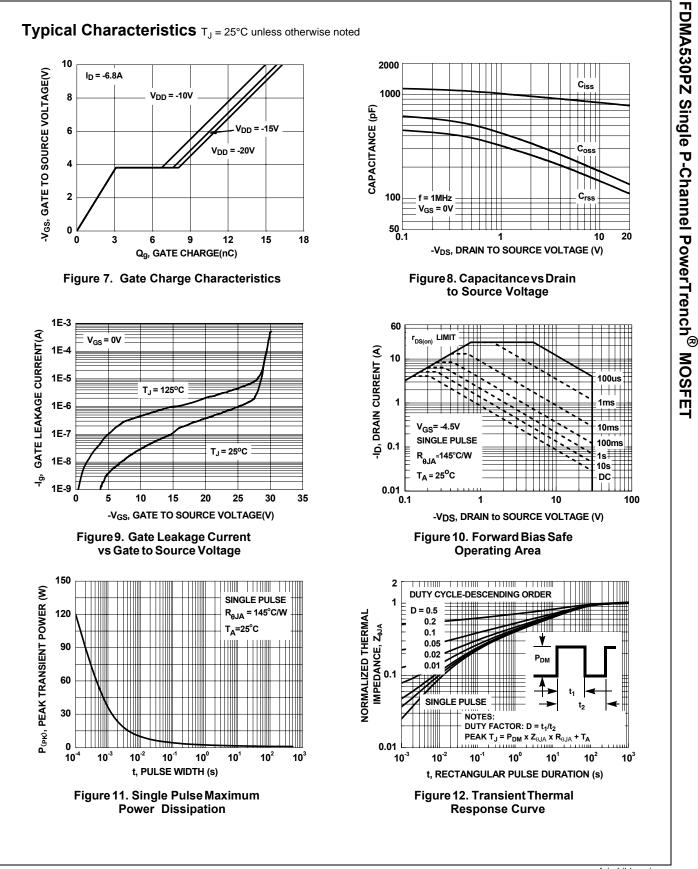
Pulse Test: Pulse Width < 300µs, Duty cycle < 2.0%.</li>
 The diode connected between the gate and the source serves only as protection against ESD. No gate overvoltage rating is implied.



FDMA530PZ Rev.B1

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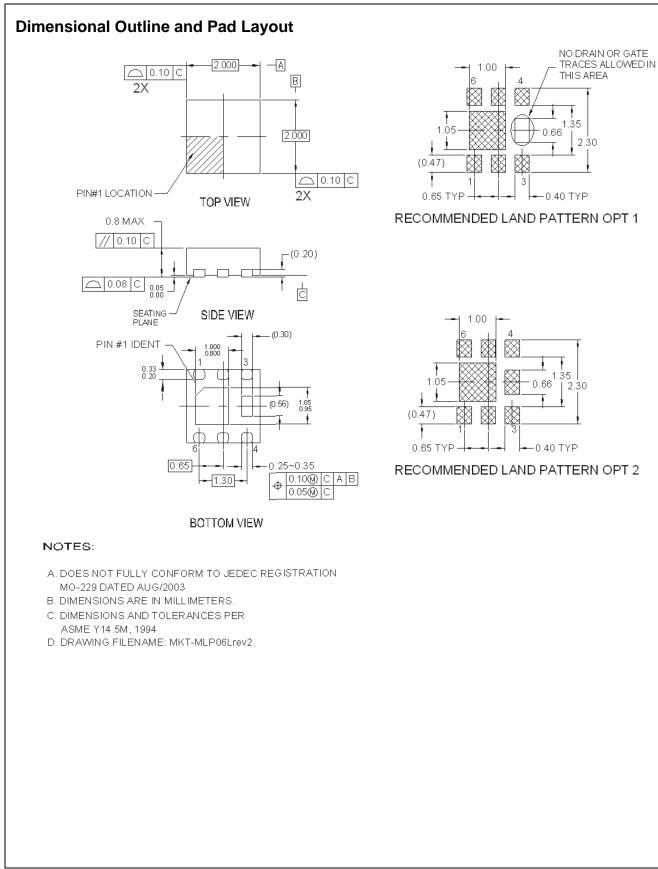
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